

<b>Notice of References Cited</b>	Application/Control No. 10/583,399		Applicant(s)/Patent Under Reexamination AHN, SOON-TAE	
	Examiner CHRISTOPHER KESSLER		Art Unit 1793	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0075250	04-2003	Ochi et al.	148/654
*	B	US-2002/0040744	04-2002	Kanisawa et al.	148/320
	C	US-			
	D	US-			
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**FOREIGN PATENT DOCUMENTS**

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